Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/620,150	GONZALEZ ET AL.		
Examiner	Art Unit		
LUU MATTHEW	2676		

SEARCHED						
Class	Subclass	Date	Examiner			
345	201	Anpo	, MC			
	دەى					
	503					
	504		-			
	202					
						

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
	L					

(INCLUDING SI	EARCH	SIRALE	:GY)	
		DATE		EXMR
* BANT SBARCH	RO	0/25/	20	۷.۷
	,			
		,		
			\dashv	